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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/774,634	02/09/2004	Richard W. Lally	88138.000005	3204	
23387	7590 06/10/2005		EXAMINER		
Stephen B. Salai, Esq. Harter, Secrest & Emery LLP 1600 Bausch & Lomb Place Rochester, NY 14604-2711			NATALINI, JE	NATALINI, JEFF WILLIAM	
			ART UNIT	PAPER NUMBER	
			2858		
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Please find below and/or attached an Office communication concerning this application or proceeding.

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	Application No.	Applicant(s)	0)
Office Action Summary	10/774,634	LALLY ET AL.	
Office Action Summary	Examiner	Art Unit	···
The MAHING DATE of this communication com	Jeff Natalini	2858	
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet with the	correspondence addre	ess
A SHORTENED STATUTORY PERIOD FOR REPLY THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a reply 1 If NO period for reply is specified above, the maximum statutory period w - Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	36(a). In no event, however, may a reply be ti within the statutory minimum of thirty (30) da vill apply and will expire SIX (6) MONTHS fron cause the application to become ABANDON	mely filed ys will be considered timely. n the mailing date of this comm ED (35 U.S.C. § 133).	nunication.
Status	•		
1) Responsive to communication(s) filed on 23 M 2a) This action is FINAL. 2b) This 3) Since this application is in condition for allowar closed in accordance with the practice under E	action is non-final. nce except for formal matters, pr		erits is
Disposition of Claims			
4) ☐ Claim(s) 1-15,25 and 36-40 is/are pending in the 4a) Of the above claim(s) 16-24 and 26-35 is/are 5) ☐ Claim(s) is/are allowed. 6) ☐ Claim(s) 1-11,13-15,25 and 36-40 is/are rejected to. 7) ☐ Claim(s) 12 is/are objected to. 8) ☐ Claim(s) are subject to restriction and/or are subject to restriction and/or are subject to by the Examine 10) ☐ The specification is objected to by the Examine 10) ☐ The drawing(s) filed on 10 June 2004 is/are: a) Applicant may not request that any objection to the or Replacement drawing sheet(s) including the correction 11) ☐ The oath or declaration is objected to by the Examine 11) ☐ The oath or declaration is objected to by the Examine 11) ☐ The oath or declaration is objected to by the Examine 11) ☐ The oath or declaration is objected to by the Examine 11.	re withdrawn from consideration ed. r election requirement. r. \[\sum \accepted \text{ accepted or b} \sum objected to drawing(s) be held in abeyance. See ton is required if the drawing(s) is objected to describe the drawing(s) is objected to the drawing(s) is objected to describe the drawing(s) is objected to the drawing(by the Examiner. se 37 CFR 1.85(a). ojected to. See 37 CFR	
Priority under 35 U.S.C. § 119	,		
12) Acknowledgment is made of a claim for foreign a) All b) Some * c) None of: 1. Certified copies of the priority documents 2. Certified copies of the priority documents 3. Copies of the certified copies of the prior application from the International Bureau * See the attached detailed Office action for a list of	s have been received. s have been received in Applicat ity documents have been receiv I (PCT Rule 17.2(a)).	ion No ed in this National Sta	age
Attachment(s)			,
Notice of References Cited (PTO-892) Notice of Draftsperson's Patent Drawing Review (PTO-948) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date 4/16/04.	4) Interview Summary Paper No(s)/Mail D 5) Notice of Informal F 6) Other:		52)

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DETAILED ACTION

Election/Restrictions

1. Applicant's election without traverse of group 1, claims 1-15, 25, and 36-40 in the reply filed on May 23, 2005 is acknowledged.

Claim Objections

- 2. Claims 1, 3-9, 12-14, 25, 26, and 37-40 are objected to because of the following informalities: Appropriate correction is required.
 - In regard to claims 1, 25, and 36, there is no antecedent basis for "the charge amplifier", this application will be examined as though this refers to disconnecting the feedback amplifier that is in the preamble of the claim.
 - In regard to claim 3, there is no antecedent basis for "the signal source", this will be examined as though this was introduced in this claim.
 - In regard to claim 4, "small value capacitor" is unclear, it will be examined as though "small value" is deleted.
 - In regard to claim 5, there is no antecedent basis for "the signal source", this will be examined as though this was introduced in this claim.
 - In regard to claim 7, "the signature response" lacks antecedent basis, this will be examined as though it depended from claim 6.
 - In regard to claim 8, "the signature response" lacks antecedent basis, this will be examined as though it depended from claim 6.

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 In regard to claim 9, "the method of claim 8 wherein the signature response of claim 10" is indefinite, examiner will examine as though it read "the method of claim 6 wherein the signature response further comprises" as it seems as though it should depend from claim 6.

- In regard to claim 12, there is no antecedent basis for "the signal source", this will be examined as though this was introduced in this claim.
- In regard to claim 13, there is no antecedent basis for "the signal source", this will be examined as though this was introduced in this claim.
- In regard to claim 14, "the test circuit" lacks antecedent basis, and "the test signal
 has an amplitude approximating the maximum allowed" is unclear, it will be
 examined as though it read the test signal has approximately the maximum
 allowed.
- In regard to claims 37-40, description of a preferred embodiment should not be included in the claims, everything except for the claimed subject matter should be deleted from the claims.

Claim Rejections - 35 USC § 103

3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

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4. Claims 1-3, 5-7, 9-11, 13, and 14 are rejected under 35 U.S.C. 103(a) as being unpatentable over Hanks et al. (5447051) in view of Shimamura et al. (5205151).

In regard to claims 1, 6, 7, 9, 25, and 36, Hanks et al. discloses a system comprising a transducer (fig 4 (7)), a feedback amplifier (7b) coupled to the transducer and a signal processing circuit (7c) coupled to an output of the amplifier, a method of testing the transducer in-situ (abstract) comprising: coupling a test signal (V from switch S1) to the transducer (col 13 line 27-31); analyzing the response of the transducer to the test signal with the signal processing circuit (col 13 line 42-46); and comparing a measured response of the transducer to a signature response wherein the signature response comprises a measured response of an unmounted transducer (col 13 line 42-50, never states the transducer is coupled to a system, col 13 line 18-23, not specifically mounted).

Hanks et al. lacks specifically stating that during testing of the transducer the amplifier is disabled.

Shimamura et al. teaches a method for testing a sensor that removes the amplifier from the circuit (col 8 line 10-14; fig 5(54)).

It would have been obvious to one with ordinary skill in the art at the time the invention was made for Hanks et al. to disable the amplifier when testing the transducer as disclosed by Shimamura et al. in order to compare determined values (without amplification error) to detect if the sensor is defective (col 8 line 10-12).

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In regard to claim 2, Hanks et al. discloses coupling an analyzer to an output of the amplifier and measuring the response of the transducer (fig 4 (7c) and col 13 line 42-46; also see fig 6a, amp-7b has output coupled to detector- 7c1).

In regard to claim 3, Hanks et al. discloses coupling impedance between the signal source and the amplifier (fig 4, resistor is connected right after the switched input, the only resistor not labeled in the figure).

In regard to claim 5, Hank et al. discloses wherein the signal source (fig 4 V through S1) generates a test signal to a resistor (only resistor not labeled, described above in claim 3) and onto an output of the amplifier (7c response).

In regard to claim 10, Hanks et al. discloses wherein the measured response is characterized by a specific amplitude (col 13 line 42-50).

In regard to claim 11, Hanks et al. discloses wherein an error signal is generated (col 3 line 26-42) when the amplitude of the signature response is outside a predetermined range (col 13 line 42-50; determines if transducer is functioning properly, it would be known there would be a cutoff point (range) where the difference between the measured signal and reference signal actually results in a malfunction).

In regard to claim 13, Hanks et al discloses wherein the signal source (fig 4, V output of S1) generates a test signal between an output of the transducer (7) and the input to the amplifier (7b).

In regard to claim 14, Hanks et al. discloses wherein the test signal has an amplitude approximating the maximum allowable (col 13 line 27-34).

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In regard to claim 37, Hanks et al. discloses wherein the measured response of an analog output transducer is determined in a test system (abstract).

Hanks et al. as modified by Shimamura disclose the claimed invention as set forth above except wherein the output of the transducer is programmed to assume a predetermined value when an unacceptable fault condition is detected.

It would have been obvious to one with ordinary skill in the art at the time the invention was made for Hanks et al. as modified by Shimamura et al. to use engineering intuition and have the transducer produce a desired, predetermined value known as an error value in order to provide all users of the system with the knowledge that a fault has been detected in the transducer.

5. Claim 4 is rejected under 35 U.S.C. 103(a) as being unpatentable over Hanks et al. (5447051) in view of Shimamura et al. (5205151) as applied to claim 3 above, and further in view of Vahavioios (3924456).

Hanks et al. as modified by Shimamura et al. disclose the claimed invention as set forth above except teaching a capacitor as the impedance.

Vahavioios discloses in a testing environment a transducer (fig 3 (12)) that has impedance components between its output and the amplifier (42), with a capacitor (53) being one a component.

It would have been obvious to one with ordinary skill in the art at the time the invention was made for Hanks et al. as modified by Shimamura et al. to have a

capacitor as an impedance component as taught by Vahavioios in order to stabilize the signal of the transducer.

6. Claim 15 is rejected under 35 U.S.C. 103(a) as being unpatentable over Hanks et al. (5447051) in view of Shimamura et al. (5205151) as applied to claim 3 above, and further in view of the admitted prior art.

Hanks et al. as modified by Shimamura et al. disclose the claimed invention as set forth above except wherein the response is normalized for various environmental conditions.

The admitted prior art states that all factors influencing measurement are monitored (paragraph 6), and it is known in the art the environment can influence a device.

It would have been obvious to one with ordinary skill in the art at the time the invention was made for Hanks et al. as modified by Shimamura et al. to normalize the response for environmental conditions as taught by the admitted prior art in order to increase the confidence in the result of measurement (paragraph 6).

7. Claims 8 and 39 are rejected under 35 U.S.C. 103(a) as being unpatentable over Hanks et al. (5447051) in view of Shimamura et al. (5205151) as applied to claim 3 above, and further in view of Lindahl et al. (5753793).

In regard to claim 8, Hanks et al. as modified by Shimamura et al. disclose the claimed invention as set forth above except wherein the signature response comprises

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a measured response of a mounted transducer to a test signal prior to initiating operations of the transducer.

Lindahl et al. discloses testing a transducer and during testing, the transducer is mounted to a surface (col 1 line 18-22).

It would have been obvious to one with ordinary skill in the art at the time the invention was made for Hanks et al. as modified by Shimamura et al. to have a measured response of a mounted transducer to a test signal before operation of the transducer as taught by Lindahl et al. in order to maintain significant measuring accuracy (col 1 line 18-20).

In regard to claim 39, Hanks et al. as modified by Shimamura et al. disclose the claimed invention as set forth above except wherein the measured response of an analog output transducer with built in test provides an additional interface for test results.

Lindahl et al. discloses wherein the results of a testing whether a transducer malfunctions are provided to a microprocessor (fig 6 (12)).

It would have been obvious to one with ordinary skill in the art at the time the invention was made for Hanks et al. as modified by Shimamura et al. to incorporate a microprocessor as an interface for the results of the test as taught by Lindahl et al. in order to control the switching between a measuring and testing state (col 4 line 17-25).

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8. Claims 38 and 40 are rejected under 35 U.S.C. 103(a) as being unpatentable over Hanks et al. (5447051) in view of Shimamura et al. (5205151) as applied to claim 3 above, and further in view of Medelius (5734596).

Hanks et al. as modified by Shimamura et al. disclose the claimed invention as set forth above except wherein the measured response of an analog output transducer is modulated with a signal reflecting the results of a detected fault condition wherein the results are compensated in the output signal.

Medelius discloses wherein a transducer system is calibrated continuously so that when the system is miscalibrated, the system is calibrated so that the output is adjusted so as to provide a proper measurement signal as a result of calibration (abstract).

It would have been obvious to one with ordinary skill in the art at the time the invention was made for Hanks et al as modified by Shimamura et al. to continuously calibrate the transducer based on results of an erroneous condition as taught by Medelius in order to provide reliable data to a centralized data acquisition system (col 1 line 25-32).

Allowable Subject Matter

9. Claim 12 is objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

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In regard to claim 12, the prior art does not teach or render obvious a signal source for generating a test signal to an output of the amplifier at a connection to the amplifier feedback in the combination as claimed.

Conclusion

10. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. Lynas et al. (3786348) teaches a system for testing a piezoelectric transducer.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Jeff Natalini whose telephone number is 571-272-2266.

The examiner can normally be reached on M-F 8-5.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Eddie Lefkowitz can be reached on 571-272-2180. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Jeff Natalini

ANJAN DEB PRIMARY EXAMINER